

S10831 is CMOS area image sensor suitable for intra-oral X-ray imaging in dental diagnosis. S10831 has 2.2 megapixels (1300  $\times$  1700) with a pixel size of 20  $\times$  20  $\mu$ m. FOP (fiber optic plate) is used as an input window, making S10831 high imagequality and long-term X-ray life. S10835 is an easy-to-use X-ray imaging module using S10831 with a cable. S10831 has 14bit ADC on chip and LVDS digital output signal. These features are to contribute cost reduction in a user's system. S10830 and S10834 (1000  $\times$  1500 pixels) are also available.

## Features

- Pixel size: 20 × 20 µm
- 1300 (H) × 1700 (V) pixel format
- Frame rate: 0.6 frames/s (MCLK=20 MHz)
- High resolution: 20 Lp/mm typ.
- 14-bit ADC (virtual dynamic range: 58 dB)
- Image data acquisition by Vdd, Vss, MCLK and MST only
- Global shutter operation
- Photodiode placed outside the active area to monitor x-ray irradiation

#### Applications

- Intra-oral X-ray imaging dental diagnosis
- General X-ray imaging
- Non-destructive inspection

These products are components for incorporation into medical and industrial device.

### Structure

Parameter	Value	Unit
Pixel size	20 × 20	μm
Pixel pitch	20	μm
Number of effective pixels	1300 (H) × 1700 (V)	pixels
Number of light-shielded pixels	Upper part: 756, 758, 760 Lower part: 1300 × 3	pixels
Image size	26 (H) × 34 (V)	mm

## Absolute maximum ratings

Parameter	Symbol	Value	Unit
Power supply	Vdd	-0.5 to +6	V
Input voltage	Vi	-0.5 to "Vdd + 0.5" (6 max.)	V
Consumption current	Idd	400	mA
Operating temperature	Topr	0 to +50	°C
Storage temperature	Tstg	-20 to +70	°C
Total dose irradiation	D	50	Gy

## Recommended operating conditions

Parameter		Symbol	Min.	Тур.	Max.	Unit
Power supply		Vdd	4.75	5.0	5.5	V
Digital input voltage*1	High	Vsigi(H)	2.4	3.3	Vdd + 0.25	V
Digital input voltage*1	Low	Vsigi(L)	0	-	0.4	

\*1: Vsigi(H) is a "High" period voltage of MST and MCLK, Vsigi(L) is a "Low" period voltage of MST and MCLK.

## Electrical characteristics (Ta=25 °C, Vdd=5 V)

Parameter		Symbol	Min.	Тур.	Max.	Unit
Master clock pulse fre	equency	f(MCLK)	1 M	20 M	40 M	Hz
Digital output format		-	Ľ	/DS differential outp	out	-
Digital output	Image sensor*2	f(DQ)	-	f(MCLK)	-	- Hz
frequency	Trigger photodiode*3	f(DO)	-	f(MCLK)/56	-	
Digital output voltage*4		V(DOmag)	-	350	-	mV
Digital output rise time*4 *5		tr(DO)	-	2	5	ns
Digital output fall time*4 *5		tf(DO)	-	2	5	ns
Video data rate	Image sensor*6	VR	-	f(MCLK)/14	-	Hz
	Trigger photodiode	VR2	-	f(MCLK)/7168	-	Hz
Start pulse interval*7		T(ST-I)	32.8 M	-	-	MCLK
Integration time	Image sensor*8		PW(MST) + 394/f(MCLK)			S
Integration time	Trigger photodiode*9	-	6608/f(MCLK)			S
Concumption current	Image sensor*10	P1	-	55	110	mA
Consumption current	Trigger photodiode*11	P2	-	25	50	mA

\*2: Refer to "Timing chart", Image data readout.

\*3: Refer to "Timing chart", Trigger photodiode data readout.

\*4: The output voltage difference between LVDS differential terminals with 100  $\boldsymbol{\Omega}$  termination

\*5: The time in output from 10% to 90% or from 90% to 10% with 2 m long cable

\*6: It takes 14 master clock pulse cycles to read out 1 pixel

\*7: It takes 32.8 M master clock pulse cycles to read out 1 frame of an image. The readout of the next frame must be started after finishing the readout of previous frame.

\*8: Refer to "Timing chart", PW(MST) is "Low" pulse width of MST (master start pulse). e.g.) When the PW(MST) is 10 ms and f(MCLK) is 20 MHz:

Integration time = 10 ms + 394/20 M = 10.0197 ms

\*9: Refer to "Timing chart", The trigger photodiode is output every 7168 MCLK cycles. The integration time is 6608 MCLK cycles, and 560 MCLK cycles are used for the reset period of trigger photodiode.

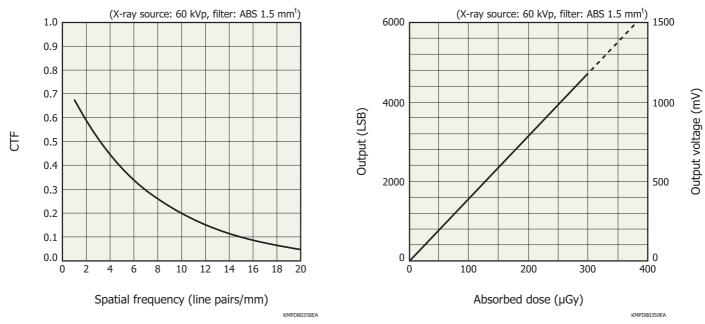
e.g.) When the f(MCLK) is 20 MHz: Integration time =  $6608/20 \text{ M} = 330.4 \text{ }\mu\text{s}$ 

\*10: The consumption current of image sensor chip only. f(MCLK)=20 MHz

\*11: The consumption current of image sensor chip only. Without 100  $\Omega$  termination (see "Output format" in P.7). f(MCLK)=20 MHz

## - Resolution (S10835)

## - Response (S10835)



## Electrical and optical characteristics (image sensor, Ta=25 °C, Vdd=5 V)

	Parameter		Symbol	Min.	Тур.	Max.	Unit
Dark output voltage (effective pixel)*12		Vdark	-	50	120	mV/s	
	voltage (enecti	ve pixel)	Ddark	-	200	490	LSB/s
Caturation ou			Vsat	0.8	1.2	-	V
Saturation ou	itput voitage		Dsat	3280	4900	-	LSB
Random nois	o*13		VRN	-	1500	4500	μV rms
Ranuominois	e		DRN	-	6.2	18	LSB rms
Dynamic range*14		DR	45	58	-	dB	
Sensitivity*15	Constitution +15		VRES	2.3	3.4	4.5	mV/µGy
Sensitivity			DRES	9.4	14	18	LSB/µGy
Saturation do	se*15		Lsat	180	350	530	μGy
Photo respon	se non-uniforn	1ity* <sup>12</sup> * <sup>16</sup>	PRNU	-	-	±30	%
	Point	White spot		-	-	20	
Dlamich	defect*17	Black spot		-	-	20	
Blemish	Cluster defea	Cluster defect*18		-	-	3	-
	Big cluster d	Big cluster defect*19		-	-	0	
Defect line*20		DL	-	-	15	lines	
X-ray resoluti	on		Reso	15	20	-	Lp/mm

\*12: Average value. Excluding defect pixels.

\*13: Integration time = 1 s

\*14: Dynamic range =  $20 \times \log \left( \frac{\text{Saturation output voltage}}{\text{Random noise}} \right)$ 

\*15: 60 kV tube voltage, no Al plate at X-ray emission

\*16: PRNU (%) =  $\Delta V / V \times 100$ 

V: average of pixel outputs,  $\Delta V$ : difference between V and min. or max. output

\*17: White spot > 1.2 V/s (4900 LSB/s) at effective pixel: 10 times of the maximum of dark output

Black spot > 50% reduction in response relative to adjacent pixels, measured at half of the saturation output

\*18: Continuous 2 to 9 point defects

\*19: Continuous 10 or more point defects. (except a defect line)

\*20: A defect line consists of 10 or more continuous point defects in 1 pixel width.

### Electrical and optical characteristics (trigger photodiode, Ta=25 °C, Vdd=5 V)

Parameter	Symbol	Min.	Тур.	Max.	Unit
Saturation voltage	Vsat	-	2.2	2.9	V
Saturation voltage	Dsat	-	450	590	LSB
Random noise	VRN	-	10	-	mV rms
Random hoise	DRN	-	2	-	LSB rms
Sensitivity* <sup>21</sup>	VRES	-	$7.9 \times 10^{2}$	-	mV/µGy
Sensitivity	DRES	-	230	-	LSB/µGy
Offset of A/D converter	-	-	430	-	LSB

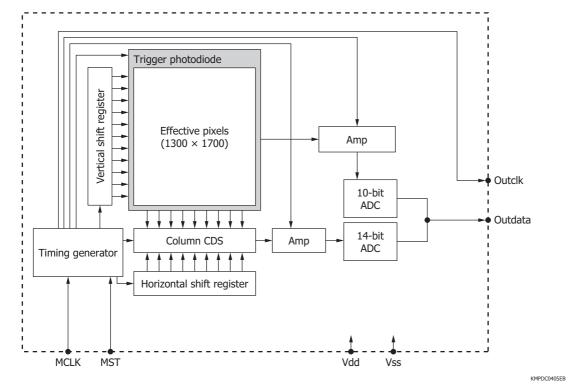
\*21: Integration time=330 µs, f(MCLK)=20 MHz

## Electrical and optical characteristics (A/D converter, Ta=25 °C, Vdd=5 V)

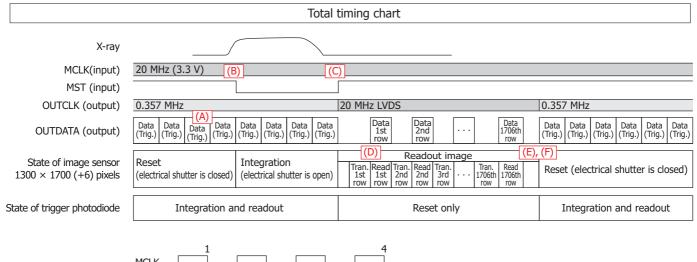
Parameter	Symbol	Image sensor	Trigger photodiode	Unit
Resolution	RESO	14	10	bit
Connection time	tCON	$1/14 \times f(MCLK)$	1/7168 × f(MCLK)	S
Conversion voltage range	-	0 to 4	0 to Vdd	V

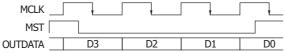


## Block diagram



## Timing chart





(A) Continuously checking some X-ray radiation with monitoring the data of trigger photodiode by an external circuit.

- (B) The MST should be set at low and integration of each pixel is to start when X-ray input is detected. The Integration time is almost same as the low width of the MST. It can be controlled by an external circuit (software, firmware, etc.).
- (C) Just after the MST is set at high, the integration is to finish and readout starts.
- (D) Each readout row has a header part, which consists of 28 high levels of the OUTDATA.
- (E), (F) After completion readout, the OUTCLK and the OUTDATA automatically move to state of trigger photodiode

KMPDC0406EA



(A) Trigger	photodiode data readout
MCLK MST	20 MHz
	$\begin{array}{cccccccccccccccccccccccccccccccccccc$
Trigger photodiode Trigger photodiode readout	
	data integration start
MCLK MST	<u>20 мнг 1000000000000000000000000000000000000</u>
Outdata	→0.357 MHz →0.357 MHz
(Hsync)	Reset Integration
Trigger photodiode	
Trigger photodiode readout	KMPDC0359EA
(C) Image	data readout start
MCLK MST	$[20] \underline{MH}_{2}] M M M M M M M M M M M M M M M M M M M$
Outdata	→0.357 MHz →20 MHz]////////////////////////////////////
(vsync) (Hsync) Pixel	
Pixel readout	Hold on Transfer of 1st row 1st pixel
Trigger photodiode Trigger photodiode readout	

Note: All on-chip timing circuits are reset at rise of MST, and the operations of trigger photodiode readout are stopped at this time.



(D) Image	data readout
MST	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$
Outclk Outdata	
(Vsync)	$\rightarrow 20 \text{ MHz} \qquad (31:21:11:0987761514131211100) (\cdot 131:21:11:09877615141312110) (\cdot 131:21:11:0017615141312110) (\cdot 131:21:11:0017615141312110) (\cdot 131:21:11:0017615141312110) (\cdot 131:21:11:0017615141312110) (\cdot 131:11:0017615141312110) (\cdot 131:11:0017615141312110) (\cdot 131:11:00176151615141312110) (\cdot 131:11:00176151615141312110) (\cdot 131:11:0017615141312110) (\cdot 131:11:11:11:11:11:11:11:11:11:11:11:11:$
(Hsync)	
Pixel	Reset Contraction
Pixel readout	1st row                                 1       1     1     1     1                 1   <t< td=""></t<>
Trigger photodiode	Reset
Trigger photodiode readout	, , , , , , , , , , , , , , , , , , ,
	KMPDC0370EB
(E) Image	readout end
MCL	< เรือ พิษัวมนินนินนินนินนินนินนินนินนินนินนินนินนิน
MCL	
	1 56
	< →20 MHz/\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\
(Vsync	
(Hsync	
Pixe	Readout
Pixel readou	t <u>1706th row</u> 1300th pixel
Trigger photodiod	
Trigger photodiod readou	
	KMPDc0371EB
(F) Image	readout end (trigger photodiode)
(i) inage	
MCLK	
MST	
Outclk	129 20 MHz 111111111111→0.357 мHz ЛИЛИЛИЛИЛИЛИЛИЛИЛИЛИЛИЛИЛИЛИЛИЛИЛИЛИЛИ
Outdata	20 MHz           →0.357 MHz
(Vsync)	
(Hsync) Pixel	
Pixel readout	Readout
Trigger photodiode	Reset Integration Reset Integration
Trigger photodiode readout	
readout	

Note: Just after image data is finished, the 1st readout of trigger photodiode is not valid, because integration time is shorter than others.



# Output format (Ta=25 °C, Vdd=5 V)

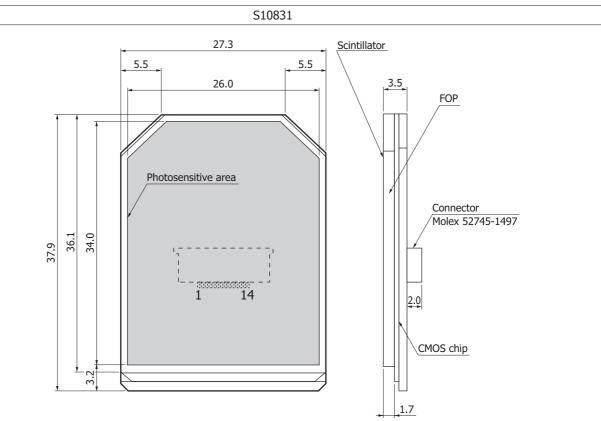
With 100 Ω termination (LVDS output mode)

Parameter	Symbol	Min.	Тур.	Max.	Unit
Differential output swing	Vod	247	-	454	mV
Offset voltage	Vos	-	1.2	-	V
Current (100 $\Omega$ termination)	I100	-	3.5	-	mA

• Without 100  $\Omega$  termination (CMOS output mode)

Par	ameter	Symbol	Min.	Тур.	Max.	Unit
Output valte se	High level	Vod	-	2.4	-	V
Output voltage	Low level	Vos	-	0	0.4	V

## Dimensional outline (unit: mm)



KMPDA0270EC

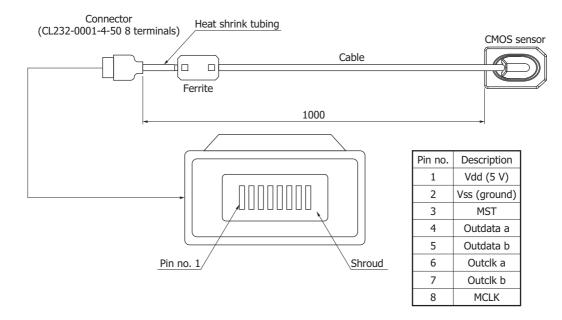
#### Pin connections

	-		
Pin no.	Description	I/O	Function
1	Vdd	Ι	Power supply voltage (5 V)
2	Vss	I	Ground
3	Outdata a	0	Video output signal (LVDS, positive)
4	Reserve	-	
5	Outdata b	0	Video output signal (LVDS, negative)
6	Reserve	-	
7	Outclk a	0	Trigger signal (LVDS, positive)
8	Reserve	-	
9	Outclk b	0	Trigger signal (LVDS, negative)
10	Reserve	-	
11	MST	I	Master start signal
12	Reserve	-	
13	MCLK	I	Master clock signal
14	Reserve	-	



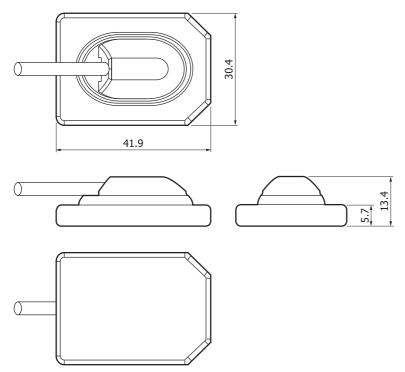
S10835





KMPDA0254EB

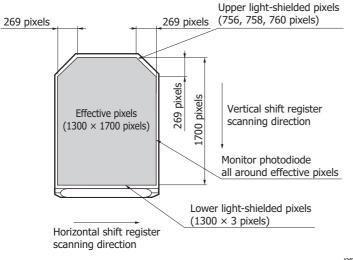
■CMOS sensor



KMPDA0255EB



## Photosensitive area



#### KMPDC0449EA

### Notice

- . This product is warranted for a period of 12 months after the date of the shipment.
- The warranty is limited to replacement or repair of any defective product due to defects in workmanship or materials used in manufacture. The warranty does not cover loss or damage caused by natural disaster, misuse (including modifications and any use not complying with the environment, application, usage and storage conditions described in this datasheet), or total radiation dose over 50 Gy (incident X-ray energy: 70 kVp) even within the warranty period.

Information described in this material is current as of April 2014.

Product specifications are subject to change without prior notice due to improvements or other reasons. This document has been carefully prepared and the information contained is believed to be accurate. In rare cases, however, there may be inaccuracies such as text errors. Before using these products, always contact us for the delivery specification sheet to check the latest specifications.

The product warranty is valid for one year after delivery and is limited to product repair or replacement for defects discovered and reported to us within that one year period. However, even if within the warranty period we accept absolutely no liability for any loss caused by natural disasters or improper product use.

Copying or reprinting the contents described in this material in whole or in part is prohibited without our prior permission.



## www.hamamatsu.com

#### HAMAMATSU PHOTONICS K.K., Solid State Division

1126-1 Ichino-cho, Higashi-ku, Hamamatsu City, 435-8558 Japan, Telephone: (81) 53-434-3311, Fax: (81) 53-434-5184

U.S.A.: Hamamatsu Corporation: 360 Foothill Road, Bridgewater, N.J. 08807, U.S.A., Telephone: (1) 908-231-0960, Fax: (1) 908-231-1218 Germany: Hamamatsu Photonics Deutschland GmbH: Arzbergerstr. 10, D-82211 Herrsching am Ammersee, Germany, Telephone: (49) 8152-375-0, Fax: (49) 8152-265-8

Germany: harrantesu Protonics Dediscriation Gripper 2016 (19) D-22211 herrschning and Ammersee, Germany, Telephone: (49) 612-237-0, Fax: (49) 6122-205-8 France: Hamamatsu Photonics France S.A.R..: 19, Rue du Saule Trapu, Parc du Moulin de Massy, Qetex, France, Telephone: 33-(1) 69 53 71 00, Fax: 33-(1) 69 53 71 10, Fax: 33-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(1) 69 53-(

Type numbers of products listed in the delivery specification sheets or supplied as samples may have a suffix "(X)" which means preliminary specifications or a suffix "(Z)" which means developmental specifications.